

NONLINEAR TRANSMISSION LINE INTEGRATED CIRCUIT

CROSS REFERENCE TO RELATED APPLICATIONS

5 The present application claims the benefit of U.S. Provisional Patent Application
No. 60/251,679, filed on December 6, 2000.

STATEMENT REGARDING FEDERALLY SPONSORED RESEARCH

Not Applicable.

FIELD OF THE INVENTION

10 The present invention relates generally to optical communication, and more
particularly, to optical signal processing utilizing electrical nonlinear transmission line
circuits.

BACKGROUND OF THE INVENTION

15 Nonlinear transmission lines (NLTLs) for generating fast time domain signals are
well known in the art. In general, a voltage-dependent nonlinearity is distributed along a
transmission line. One conventional NLTL implementation is an integrated circuit on
20 semiconductor material including diodes and transmission lines. The nonlinear
dependence of voltage and reverse-biased capacitance of the diode reduce the transient of
a time domain signal applied to the input of the NLTL.

25 An exemplary NLTL is shown and described in U.S. Patent No. 5,804,921 to
McEwan et al. Typical NLTL circuits are formed from Gallium Arsenide (GaAs) and can
produce transients on the order of several hundred femtoseconds.

30 GaAs semiconductor material has certain disadvantages compared to the widely
known and used Silicon (Si) material, among which are cost and mechanical stability. Si
wafers are relatively inexpensive and can be produced at greater sizes, reducing cost of

the final integrated circuit. GaAs has the advantage of better drift mobility compared to Si, resulting in shorter transients at the output. However, sub-picosecond transients are not needed for certain applications.

5 Conventional return-to-zero (RZ) optical transmitters for modulating data streams include two Lithium-Niobate optical modulators, one for generating an optical pulse train and one for modulating the data onto the pulse stream. However, such an arrangement is relatively complex and expensive.

10 It would, therefore, be desirable to generate a pulse train in the electrical domain using an all-silicon nonlinear transmission line and pulse-forming circuit, modulate the pulse train in the electrical domain with data, and modulate the electrical RZ data stream onto an optical carrier using a single optical modulator.

15 SUMMARY OF THE INVENTION

 The present invention provides an integrated nonlinear transmission line and pulse-forming network. The pulse-forming network can include a reverse-biased diode coupled in series with a conductive path of the nonlinear transmission line. With this arrangement, the nonlinear transmission line and the pulse-forming network can be easily
20 integrated in an all-silicon structure.

 In one aspect of the invention, an all-silicon integrated circuit includes a nonlinear transmission line and a pulse-forming circuit. In one embodiment, the nonlinear transmission line is monolithically integrated and includes a high-impedance co-planar
25 waveguide and reverse-biased Schottky diodes. The diodes are periodically integrated into the waveguide at predetermined spacings. The pulse-forming network can include a capacitance in the form of a reverse-biased diode coupled to the nonlinear transmission line.

The nonlinear transmission line and the pulse-forming circuit can be integrated in an all-silicon configuration. The circuit can be fabricated using a high yield Si/SiGe HBT process to provide compatibility with bipolar transistor process technology. With this process, the nonlinear transmission line can be integrated with heterostructure bipolar transistors for high-frequency circuit operation.

In a further aspect of the invention, an electro-optical system provides high-speed signal transmission with optical signal processing. In an exemplary embodiment, a data stream from a nonlinear transmission line and pulse-forming network is provided to an optical modulator that receives a laser signal. The modulator outputs an optical signal, such as return-to-zero pulses, having relatively small, e.g., 27 ps, pulse widths.

The electro-optical system can further include an electrical gate, such as a dual gate transistor, for modulating data, such as data coming from a bit error rate test set, onto an electrical RZ pulse stream. The gate output as well as a laser signal are provided to the optical modulator, which can generate a high-speed, e.g., ten Gbit per second, modulated return-to-zero signal.

In a further aspect of the invention, an electro-optical transmitter is integrated on a silicon substrate. In one embodiment, a nonlinear transmission line, a pulse-forming network, a gate, a laser, and a modulator are disposed on a high-resistivity silicon substrate. This arrangement facilitates manufacture of the system with concomitant reductions in cost and complexity.

BRIEF DESCRIPTION OF THE DRAWINGS

The invention will be more fully understood from the following detailed description taken in conjunction with the accompanying drawings, in which:

FIG. 1 is a schematic block diagram of a nonlinear transmission line coupled to a pulse-forming network in accordance with the present invention;

FIG. 2 is a schematic diagram of an exemplary circuit implementation of the circuit of FIG. 1;

FIGS. 3A-3C are graphical representations of signals at various locations in the circuit of FIG. 1;

FIG. 4 is a pictorial representation of a fabricated nonlinear transmission line in accordance with the present invention;

FIG. 5 is a block diagram of an electro-optical system for generating optical pulses utilizing the nonlinear transmission line and pulse-forming network of FIG. 1;

FIG. 6 is block diagram of an electro-optical system for generating a modulated return-to-zero bit stream with bit error rate measurement capability;

FIG. 7 is a schematic representation of an electro-optical system for generating a modulated return-to-zero bit stream integrated on a substrate in accordance with the present invention; and

FIG. 8 is a graphical depiction of a comparison of RZ and NRZ for an electro-optical system in accordance with the present invention.

DETAILED DESCRIPTION OF THE INVENTION

FIGS. 1-2 show a circuit 100 including a nonlinear transmission line (NLTL) 102 coupled to a pulse-forming network 104 in accordance with the present invention. In an exemplary embodiment, the NLTL 102 includes a series of reverse-biased diodes D1-N (FIG. 2), such as Schottky diodes, integrated at predetermined locations between impedances Z_0 - Z_N , which can be provided as inductive elements. The nonlinear transmission line 102 utilizes the voltage-dependent capacitances of the reverse-biased

Schottky diodes D1-N, which are distributed along a high impedance transmission line 106 to introduce nonlinear wave propagation effects.

The capacitances and inductances of the nonlinear transmission line elements decrease in a direction of signal propagation such that the time constant, i.e., $(LC)^{1/2}$, concomitantly decreases. This arrangement, which can be referred to as a shockwave nonlinear transmission line, steepens a leading or falling edge of a large time-domain signal in a manner similar to a wave-breaking effect of water on beaches.

The pulse-forming network 104 can include a reverse-biased diode DPF coupled to the nonlinear transmission line NLTL. The pulse-forming network 104 differentiates the output from the NLTL 102. In one embodiment, the reverse-biased diode DPF of the pulse-forming network 104 is coupled to the NLTL 102 in the center of a waveguide, such as the waveguide shown in FIG. 4.

The pulse-forming network 104 uses the capacitance of the reverse-biased diode DPF to differentiate the saw-tooth output waveform of the NLTL. The capacitance of the reverse-biased diode corresponds to the space charge capacitance of the diode. In one particular embodiment, the capacitance is about 60 fF for a pulse width of 7 ps and about 15 fF for a pulse width of 1 ps.

As shown in FIGs. 3A-3C, a sine wave input (FIG. 3A) to the nonlinear transmission line 102 by a signal generator 107 (see Fig. 1) produces a saw-tooth signal (FIG. 3B). The pulse-forming network 104 receives the saw-tooth signal and generates an impulse signal (FIG. 3C).

FIG. 4 shows an exemplary implementation of the nonlinear transmission line 102 of FIGs. 1-2 disposed within a waveguide 108. Each of the reverse-biased diodes D1-N extends from the center conductor to the two grounds on either side. For example, the first diode D1 is coupled to the transmission line or center conductor 106 and first and

second grounded walls 108a, 108b of the waveguide. In the illustrated embodiment, the waveguide 108 is a high impedance co-planar waveguide, which is readily understood by one of ordinary skill in the art.

5 The illustrated co-planar waveguide 108 has about a 20 μm center conductor 106 width, about a 40 μm air gap, and about 80 μm ground conductor width. The diode epitaxy in this example is homogeneous, but can also be pulse-doped or exponential. The doping concentration and thickness determine the behavior of the diode, e.g., the breakdown voltage, the cut-off frequency and the capacitance swing. In this example, the
 10 doping N_D is about $3 \times 10^{16} \text{cm}^{-3}$ and the thickness t is about 550 nm. The diode spacing is tapered to have good compression at higher losses at the input of the line and less compression but also lower losses at the output of the line. The spacing in the illustrated embodiment was done exponentially decreasing, starting at 300 μm and going down to 50 μm .

15 In an exemplary embodiment, the NLTL 102 of the present invention is fabricated from high-resistivity silicon, which renders the NLTL compatible with silicon millimeter wave integrated circuits (SIMMWIC). As used herein, high-resistivity silicon refers to a silicon substrate having a resistivity greater than about 500 Ohm cm. In one embodiment,
 20 the NLTL is integrated into a Si/SiGe HBT process to facilitate integration of Si/SiGe heterostructure bipolar transistors. This is in contrast to conventional NLTLs that are fabricated from Gallium Arsenide (GaAs). Exemplary SIMMWIC integrations include an integrated time domain sampler with additional functionality provided by a heterostructure bipolar transistor circuit, such as an operational amplifier. Further
 25 SIMMWIC integrations will be readily apparent to one of ordinary skill in the art.

FIG. 5 shows an electro-optical system 200 in accordance with the present invention including a NLTL 202 and pulse-forming network 204 described above. A signal generator 206 provides a signal, such as a sine wave signal, to the NLTL 202. The
 30 output of the pulse-forming network 204 is coupled to an optical modulator 208, which

also receives a signal from a laser 210 via a polarization controller 212. The modulator 208 generates optical pulses 214 that can be transmitted to a desired location.

In an exemplary embodiment, the modulator 208 produces 10 Gbit/s RZ optical pulses with about 27 picoseconds full-width-at-half-maximum (FWHM). The pulses can be observed on an oscilloscope after conversion of the optical signal to the electrical domain.

FIG. 6 shows an electro-optical system 300 including a bit error rate test (BERT) set 302 that provides an input signal, e.g., 10 Gbit/s NRZ, to a gate 304, such as a dual-gate field effect transistor (FET), and a 10 GHz sine wave, for example, to a nonlinear transmission line and pulse-forming network 306. Dual-gate transistors are well known to one of ordinary skill in the art. The gate 304 modulates the output signal from the NLTL/PFN circuit 306 with the BERT signal and provides the modulated signal to an optical modulator 308, such as a LiNbO₃ Mach-Zehnder modulator or electro-absorption modulator. The modulator 308 also receives a CW optical carrier signal from a laser 310 via a polarization controller 312. The dual-gate FET 304 samples the NRZ signal on one gate with the short electrical pulses applied to the other gate. The pulses are applied to the faster gate of the FET.

An optical-to-electrical signal converter 314 can convert the modulator 308 output signal to the electrical domain for amplification by a variable gain amplifier 316, for example. A BERT receiver 318 can then determine a bit-error-rate (BER) for the system.

It is understood that a wide variety of gates, modulators, and data formats can be used. Gates can include switching circuits that can be rapidly controlled, such as a diode switch. Modulators can include optical modulators that are capable of relatively high speeds, such as electro-absorption, LiNbO₃ and polymer modulators. Exemplary data formats include RZ and NRZ.

As shown in FIG. 7, the NLTL/PF circuit 306, the electro-absorption modulator 308, the gate 304 and the laser 310, such as a DFB laser in a flip-chip module, are integrated on a single silicon substrate 350. In one particular embodiment, a Si/SiGe HBT process is used to fabricate the device. This arrangement significantly reduces system complexity, decreases overall fabrication costs, and minimizes equipment failures.

In an exemplary embodiment, a 10 GHz sine wave at a power of 24 dBm is applied to the input of the NLTL that provides an output signal to a driver amplifier and a 10 GHz LiNbO₃ Modulator to produce about 27ps FWHM optical pulses. The optical pulses in this measurement are chirped, since the driver is only connected to one side of the modulator. The bandwidth-FWHM product of the pulses is in the order of 0.4, which would be improved to no chirp by using an electrical amplifier to drive both modulator sides.

EXAMPLE

An electrical pulse train from an all silicon NLTL and pulse-forming circuit was modulated with a pseudo-random bit stream (length $2^{31}-1$) by applying a NRZ signal from a bit-error-rate test set (BERT) to one gate of a dual-gate field effect transistor in a hybrid package and the pulse train to the other gate. The resulting RZ pulses at the gate output were amplified in order to directly drive a 10-GHz LiNbO₃ modulator, that followed a 1.55 micrometer semiconductor laser. After detection by a 13-GHz optical-to-electrical converter, the output was amplified and the error rate was measured.

Before taking measurements, certain parameters were optimized, such as the modulator DC-bias, NLTL bias, decision threshold and the phase of the signal. FIG. 8 shows measured bit-error-rates (BER) as a function of the received power at 10 Gbit/s, which indicates a receiver sensitivity of about -18.2 dBm at a bit-error-rate of 10^{-9} . For comparison, an optimized NRZ measurement without NLTL and dual-gate FET was also performed. As can be seen in FIG. 8, the gain in sensitivity is about 1.5 dB for RZ over

NRZ signaling. Integrating a transistor directly with the NLTL in a Si/SiGe HBT process provides about a 2 dB improvement due to a reduction in wiring parasitics.

The present invention provides a system for generating relatively short, e.g., 27 ps, FWHM optical pulses using an all-silicon nonlinear transmission line integrated with a pulse-forming network. The system utilizes the all-silicon NLTL to transmit optical data at 10 Gbit/s data rates. The integrated structure of the invention reduces complexity and cost.

One skilled in the art will appreciate further features and advantages of the invention based on the above-described embodiments. Accordingly, the invention is not to be limited by what has been particularly shown and described, except as indicated by the appended claims. All publications and references cited herein are expressly incorporated herein by reference in their entirety.

What is claimed is: